

Search Notes**Application/Control No.**

10/655,423

Examiner

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Applicant(s)/Patent under Reexamination

JUNG ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	696	8/10/2005	BT
438	700	8/10/2005	BT
438	706	8/10/2005	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search inventors' name and keywords using USPAT, USPG-PUB, EPO, JPO, DERWENT databases	8/10/2005	BT
438/697 text only	8/10/2005	BT

INTERFERENCE SEARCHED

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